GP2S29

Features

- 1. Wide range of detecting distance (Detecting distance : 1 to 20mm)
- 2. Prism system
- 3. High sensitivity (S/N ratio : 75)
- Easy circuit design in sub sequent stage due to large output current

Applications

- 1. Printers
- 2. Facsimiles
- 3. DAT
- 4. Copiers
- 5. LBPs

	Absolute Maximu	ngs	(Ta=25°C)	
	Parameter	Symbol	Rating	Unit
Input	*1 Forward current	IF	50	mA
	*2 Peak forward current	IFM	1	Α
	Reverse voltage	VR	6	V
	*1 Power dissipation	Р	75	mW
Output	Collector-emitter voltage	VCEO	35	V
	Emitter-collector voltage	VECO	6	V
Out	Collector current	ICP	20	mA
-	*1Collector dissipation	Pc	75	mW
	*1 Total power dissipation	Ptot	100	mW
Operating temperature		Topr	-25 to +85	°C
Storage temperature		Tstg	-40 to +100	°C
	*3 Soldering temperature	Tsol	260	°C

*1 The derating factors of absolute maximum ratings due to ambient temperature are shown in Fig.1 to 2

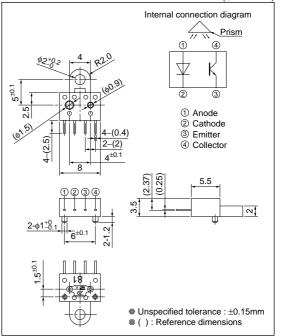
*2 Pulse width<=100µs, Duty ratio:0.01

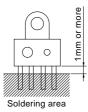
*3 For 3s

Long Focal Distance, Reflective Type Photointerrupter

Outline Dimensions

(Unit : mm)





Elect	ro-optical C	haracteristics	5				(Ta=25°C)
Parameter			Symbol	Conditions	MIN.	TYP.	MAX.	Unit
	Forward voltage		VF	IF=20mA	-	1.25	1.4	V
Input	Peak forward voltage		VFM	I _{FM} =0.5A	_	3	4	V
	Reverse current		Ir	V _R =3V	-	-	10	μA
Output	Collector dark current		Iceo	Vce=20V	-	-	100	nA
	*4 Collector current		Ic	Vce=5V, IF=20mA	0.2	-	2.4	mA
	*5 Leak current		ILEAK	VCE=5V, IF=20mA	-	-	10	μΑ
Transfer	Signal to noise ratio		S/N	Ic/Ileak	75	-	-	-
charac-	^{*4} Collector-emitter saturation voltage		VCE (sat)	Ic=0.1mA		0.1	0.4	v
teristics				IF=40mA	_			
	Response time	Rise time	tr	VCE=2V, IC=0.5mA	_	38	90	μs
		Fall time	tſ	RL=1k Ω , d=8mm	_	48	110	μs

*4 Refer to Fig.13 *5 Refer to Fig.15

Fig.1 Forward Current vs. Ambient



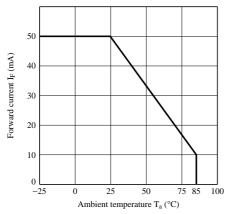


Fig.3 Peak Forward Current vs. Duty Ratio

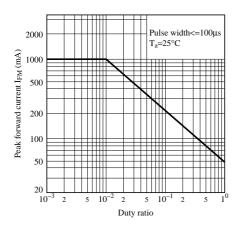


Fig.2 Power Dissipation vs. Ambient Temperature

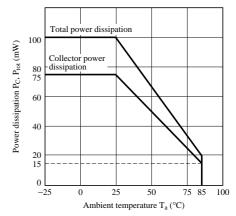


Fig.4 Forward Current vs. Forward Voltage

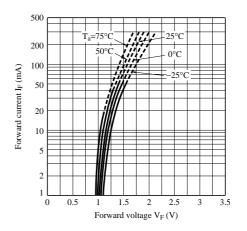
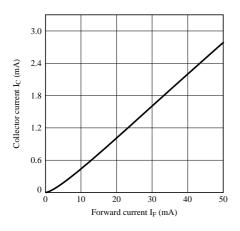
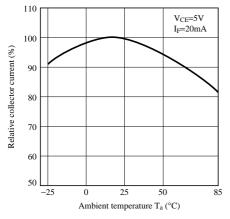


Fig.5 Collector Current vs. Forward Current









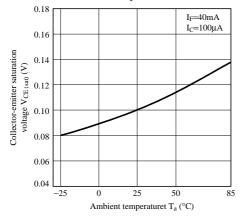


Fig.6 Collector Current vs. Collector-emitter Voltage

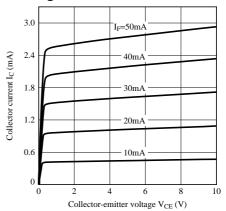


Fig.8 Collector Dark Current vs. Ambient Temperature

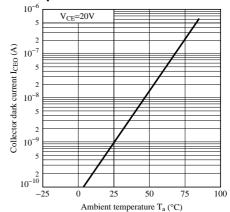
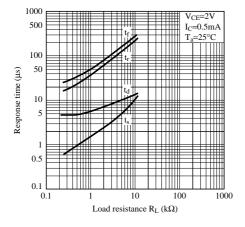
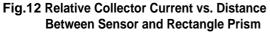


Fig.10 Response Time vs. Load Resistance





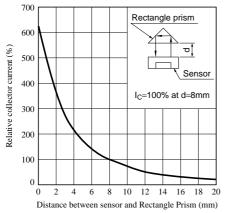


Fig.14 Voltage Gain vs Frequency

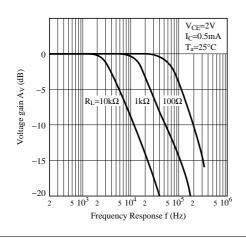


Fig.11 Test Circuit For Response Time

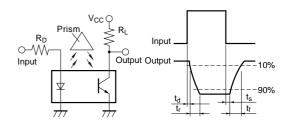


Fig.13 Measuring Configulation of Collector Current

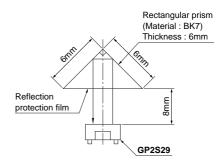
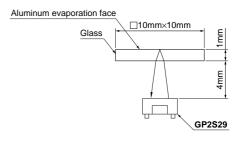


Fig.15 Measuring Configulation of Leak Current



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